Irradiation effect on the electrical characteristics of an AlGaAs/GaAs based solar cell: Comparison between electron and proton irradiation by numerical simulation

W. Laiadi, Af. Meftah, N. Sengouga *, Am. Meftah

Laboratory of Metallic and Semicondcuting Materials (LMSM), Université de Biskra, BP 145, 07000 Biskra RP, Algeria

Abstract

In this work we use numerical simulation to make a comparison between the effect of electron and proton irradiation on the current voltage (J–V) characteristics of a GaAs based solar cell. This is an extension of a previous work in which we have demonstrated that the use of a gradual gap AlxGa1_xAs window improves the resistivity of the cell to electron irradiation. In this paper we use the gradual gap AlxGa1_x layer as window material on the top of the GaAs cell and we study the effect of its thickness on the output parameters of the cell exposed to 1 MeV electron and proton irradiation. The external cell parameters are: the short circuit current (Jsc), the open circuit voltage (Voc), the fill factor (FF) and the conversion efficiency (g). Our results show that Jsc is more sensitive to electron irradiation while Voc is a little bit more sensitive to proton irradiation. This gives nearly the same effect of the two types of irradiation on the conversion efficiency of the cell. We found also that the increase of the gradual AlxGa1_xAs window thickness from 0.09 to 0.3 Im improves the resistivity of the solar cell to irradiation.

Keywords:

AlGaAs window
GaAs solar cell
Electrons
Protons
Irradiation
Numerical simulation